

Notice of References Cited	Application/Control No. 10/051,185	Applicant(s)/Patent Under Reexamination ONO ET AL.	
	Examiner Thoi V Duong	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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	U	US 2002/0024627 A1, Sakamoto et al., Feb. 28, 2002
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